



Silicon FS Planar IGBT



BT25T120ANF

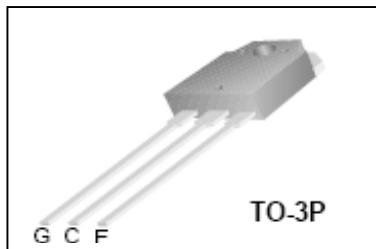
General Description:

Using HUAJING's proprietary trench design and advanced FS(field stop) technology, the 1200V Trench FS-IGBT offers superior conduction and switching performances, high avalanche ruggedness.

V_{CES}	1200	V
I_C	25	A
P_{tot} (T_C=25°C)	312	W
V_{CE(SAT)}	1.9	V

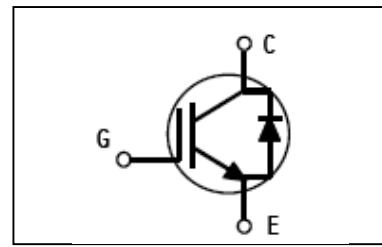
Features:

- | Trench FS Technology, Positive temperature coefficient
- | Low saturation voltage: V_{CE(sat)}, typ = 1.9V
@ I_C = 25A and T_C = 25°C
- | Extremely enhanced avalanche capability



Applications:

Power switch circuit of induction cooker(IH).



Absolute Maximum Ratings

(T_C= 25°C unless otherwise specified):

Symbol	Parameter	Rating	Units
V _{CES}	Collector-Emitter Voltage	1200	V
V _{GES}	Gate- Emitter Voltage	±20	V
I _C	Collector Current	50	A
	Collector Current @TC = 100 °C	25	A
I _{CM} ^{a1}	Pulsed Collector Current	75	A
I _F	Diode Continuous Forward Current @TC = 100 °C	25	A
I _{FM}	Diode Maximum Forward Current	75	A
P _D	Power Dissipation @ TC = 25°C	312	W
	Power Dissipation @TC = 100 °C	125	W
T _J , T _{stg}	Operating Junction and Storage Temperature Range	-55 to +150	°C
T _L	Maximum Temperature for Soldering	300	°C

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Units
R _{θJC}	Thermal Resistance, Junction to case for IGBT	--	0.4	°C/W
R _{θJC}	Thermal Resistance, Junction to case for Diode	--	2	°C/W



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$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	--	40	°C/W
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Electrical Characteristics of the IGBT ($T_c = 25^\circ C$ unless otherwise specified):

OFF Characteristics						Units	
Symbol	Parameter	Test Conditions	Rating				
			Min.	Typ.	Max.		
V_{CES}	Collector-Emitter Breakdown Voltage	$V_{GE}=0V, I_{CE}=250\mu A$	1200	--	--	V	
I_{CES}	Collector-Emitter Leakage Current	$V_{GE}=0V, V_{CE}=V_{CES}$	--	--	1.0	mA	
$I_{GES(F)}$	Gate to Emitter Forward Leakage	$V_{GE}=+20V$	--	--	+250	nA	
$I_{GES(R)}$	Gate to Source Reverse Leakage	$V_{GE}=-20V$	--	--	-250	nA	

ON Characteristics						Units	
Symbol	Parameter	Test Conditions	Rating				
			Min.	Typ.	Max.		
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C=25A, V_{GE}=15V$	--	1.9	2.5	V	
$V_{GE(TH)}$	Gate Threshold Voltage	$I_C=15mA, V_{CE}=V_{ge}$	4.5	6.2	7.5	V	
Pulse width $t_p \leq 380\mu s, \bar{\delta} \leq 2\%$							

Dynamic Characteristics						Units	
Symbol	Parameter	Test Conditions	Rating				
			Min.	Typ.	Max.		
C_{ies}	Input Capacitance	$V_{CE}=25V, V_{GE}=0V$ $f=1MHz$	--	4688	--	pF	
C_{oes}	Output Capacitance		--	82	--		
C_{res}	Reverse Transfer Capacitance		--	63	--		

Resistive Switching Characteristics						Units	
Symbol	Parameter	Test Conditions	Rating				
			Min.	Typ.	Max.		
$t_{d(ON)}$	Turn-on Delay Time	$V_{CE}=600V, I_C=25A$ $V_{GE}=15V, R_g=10\Omega$ Inductive Load	--	20	--	ns	
t_r	Rise Time		--	21	--		
$t_{d(OFF)}$	Turn-Off Delay Time		--	109	--		
t_f	Fall Time		--	93	--		
E_{on}	Turn-On Switching Loss		--	1.85	2.1	mJ	
E_{off}	Turn-Off Switching Loss		--	0.72	1.7		
E_{ts}	Total Switching Loss		--	2.57	3.8		
Q_g	Total Gate Charge	$V_{CE}=600V, I_C=25A$ $V_{GE}=15V$	--	177	274	nC	
Q_{ge}	Gate to Emitter Charge		--	16	26		
Q_{gc}	Gate to Collector Charge		--	61	94		



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Electrical Characteristics of the DIODE (T_c= 25°C unless otherwise specified):

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V _{FM}	Diode Forward Voltage	I _F =25A	--	1.35	2.7	V
T _{rr}	Reverse Recovery Time		--	535	585	ns
I _{rr}	Diode Peak Reverse Recovery Current	I _F =25A di/dt=200A/uS	--	43	85	A
Q _{rr}	Reverse Recovery Charge		--	12.7	15	uC

Pulse width t_{tp}≤380μs, δ≤2%

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature

Typical Performance Characteristics

Figure 1. Typical Output Characteristics

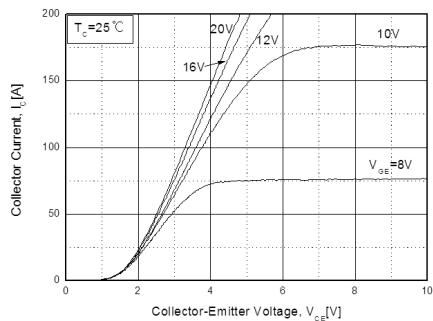


Figure 2. Typical Saturation Voltage Characteristics

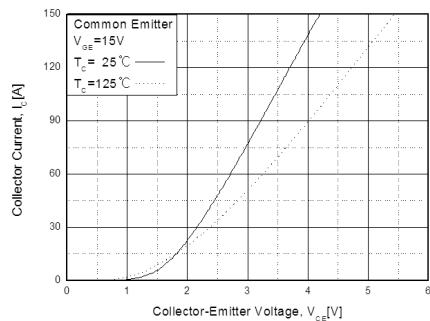


Figure 3. Saturation Voltage vs. Case Temperature at Variant Current Level

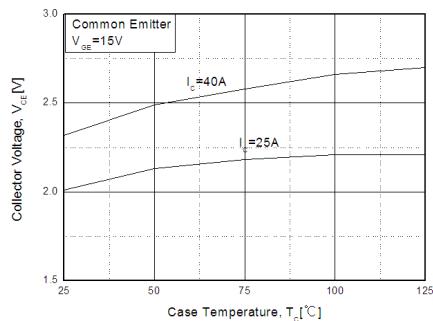


Figure 4. Saturation Voltage vs. VGE

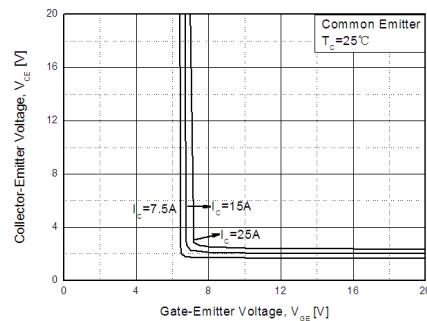


Figure 5. Saturation Voltage vs. VGE

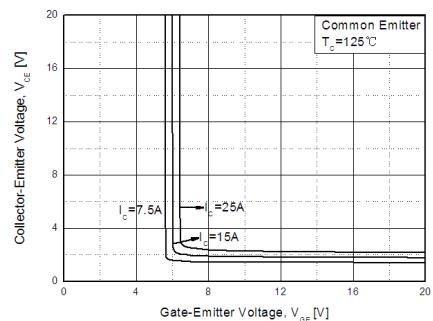
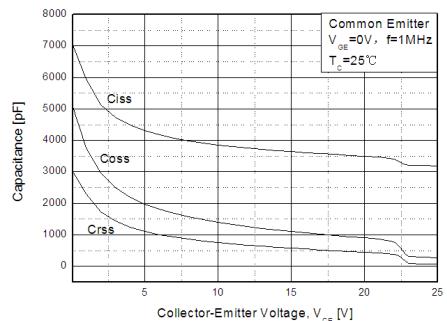
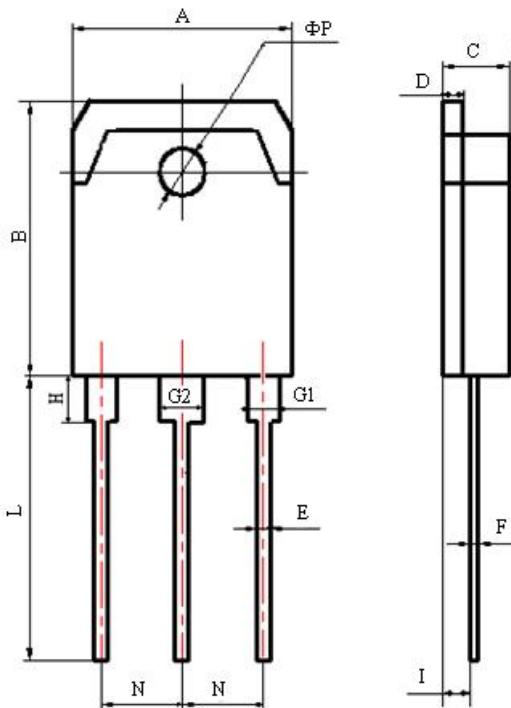


Figure 6. Capacitance Characteristics



**Package Information:**

Items	Values(mm)	
	MIN	MAX
A	15.10	15.90
B	19.30	20.30
C	4.70	4.90
D	1.40	1.60
E	0.90	1.10
F	0.50	0.70
G1	2.00	2.20
G2	3.00	3.20
H	3.00	3.70
I	1.20	1.60
	2.70	2.90
L	19.00	21.00
N	5.25	5.65
Φ P	3.10	3.30

TO-3P(N) Package



The name and content of poisonous and harmful material in products

Part's Name	Hazardous Substance					
	Pb	Hg	Cd	Cr(VI)	PBB	PBDE
Limit	≤0.1%	≤0.1%	≤0.01%	≤0.1%	≤0.1%	≤0.1%
Lead Frame	○	○	○	○	○	○
Molding Compound	○	○	○	○	○	○
Chip	○	○	○	○	○	○
Wire Bonding	○	○	○	○	○	○
Solder	×	○	○	○	○	○
Note	Means the hazardous material is under the criterion of SJ/T11363-2006. Means the hazardous material exceeds the criterion of SJ/T11363-2006. The plumbum element of solder exist in products presently, but within the allowed range of Eurogroup's RoHS.					

Warnings

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. It is suggested to be used under 80 percent of the maximum ratings of the device.
 2. When installing the heatsink, please pay attention to the torsional moment and the smoothness of the heatsink.
 3. IGBTs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
 4. This publication is made by Huajing Microelectronics and subject to regular change without notice.

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